

Substitute for Form 1449A/PTO <b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b> <small>(Use as many sheets as necessary)</small>		<small>Complete if Known</small>	
 <small>Sheet _____ of _____ Total Sheets</small>		<b>Application Number</b>	10/014218
		<b>Filing Date</b>	October 22, 2001
		<b>First Named Inventor</b>	Wu et al.
		<b>Group Art Unit</b>	2877
		<b>Examiner Name</b>	Unknown
<b>Attorney Docket No:</b> 1010.8079U1			

US PATENT DOCUMENTS						
Examiner Initials*	USP Document Number	Publication Date	Name of Patentee or Applicant of cited Document	Class	Subclass	Filing Date If Appropriate
<i>He</i>	3,612,691	10/12/1971	Schwartz	—	—	
<i>He</i>	6,323,987	11/27/2001	Rinaudo	—	—	

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OTHER DOCUMENTS -- NON PATENT LITERATURE DOCUMENTS						
Examiner Initials*	Cite No <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.				T <sup>2</sup>

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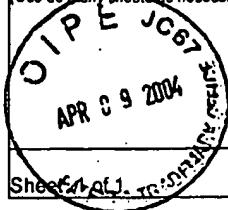
*Shi Ku*

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**INFORMATION DISCLOSURE  
STATEMENT BY APPLICANT**

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Sheet 1 of 1

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Application Number	10/014218
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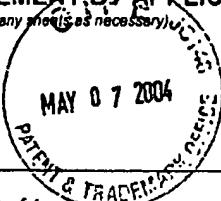
Examiner Initials*	Cite No <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T <sup>2</sup>

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		Application Number	10/014218
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		First Named Inventor	Wu et al.
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		Examiner Name	Unknown
Sheet 1 of 1		Attorney Docket No: 1010.8079U1	

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OTHER DOCUMENTS -- NON PATENT LITERATURE DOCUMENTS			
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Group Art Unit	2877
Examiner Name	Unknown
Attorney Docket No: 1010.8079U1	

Sheet 1 of 1

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Examiner Initials*	Cite No <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T <sup>2</sup>
		WL500 Wavelength Locking Device, JDS Uniphase, 11/99, 13 pages, MKT-DS-0153 Rev. B, JDS Uniphase Corporation, Canada	

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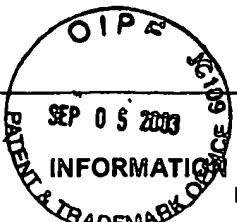
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sk		5,042,898	08/27/91	Morey, et al.	—	—	
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<i>Sk</i>	S. E. Harris, et al., "Optical Network Synthesis Using Birefringent Crystals.* I. Synthesis of Lossless Networks of Equal-Length Crystals", <i>Journal of the Optical Society of America</i> , 54:10, 1267-1279 (October 1964).
<i>Sk</i>	09/694691, Han et al., filed October 23, 2000, "METHOD AND APPARATUS FOR ADJUSTING AN OPTICAL ELEMENT TO ACHIEVE A PRECISE LENGTH"

Examiner: Shi G. Li Date Considered: 10/19/04



 <p><b>INFORMATION DISCLOSURE STATEMENT</b> PTO Form 1449</p>	Docket Number	Serial Number
	00980.1079-US-01	10/014218
	Applicant(s) WU et al.	
	Filing Date 10/22/2001	Group Art Unit 2877

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	Applicant(s)	
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					Applicant(s) WU et al.		
					Filing Date 10/22/2001	Group Art Unit 2877	
<b>U.S. PATENT DOCUMENTS</b>							
EXAMINER'S INITIALS	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB-CLASS	FILING DATE (IF APPROPRIATE)
<i>sk</i>		5,486,948	01/23/96	Imai et al.	—	—	
<b>RECEIVED</b> JUL 7 2003 TECHNOLOGY CENTER 2800							
<b>FOREIGN PATENT DOCUMENTS</b>							
EXAMINER INITIALS	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION
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Examiner: SL Gi Li Date Considered: 10/19/04



<b>INFORMATION DISCLOSURE STATEMENT</b> PTO Form 1449	Docket Number	Serial Number
	00980.1079-US-01	10/014218
	Applicant(s)	
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<b>Applicant(s)</b> WU et al.		
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<b>INFORMATION DISCLOSURE STATEMENT</b> PTO Form 1449		<b>Docket Number</b> 00980.1079-US-01	<b>Serial Number</b> 10/014218
<b>Applicant(s)</b> WU et al.		<b>Filing Date</b> 10/22/2001	<b>Group Art Unit</b> 2877

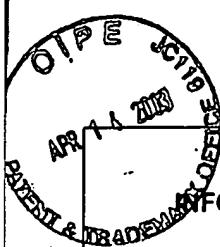
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Applicant(s) <b>WU et al.</b>		
Filing Date <b>10/22/2001</b>	Group Art Unit <b>2877</b>	

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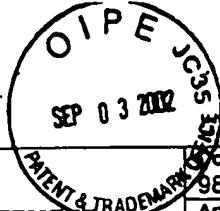
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 <b>INFORMATION DISCLOSURE STATEMENT</b> PTO Form 1449					Docket Number		Serial Number	
					00980.1079-US-01		10/014218	
					Applicant(s) WU et al.		Filing Date 10/22/2001	
<b>U.S. PATENT DOCUMENTS</b>								
EXAMINER INITIALS	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB-CLASS	FILING DATE (IF APPROPRIATE)	
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<i>AK</i>		GB 2 245 381 A	01/02/92	Great Britian	—	—	YES	NO
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		Filing Date 10/22/01	Group Art Unit 2877		

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<i>sh</i>		4,484,806	11/27/84	Onishi et al.	—	—	
<i>sh</i>		6,052,223	04/18/00	Yoneyama et al.	—	—	
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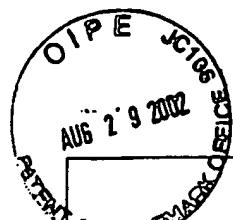
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EXAMINER INITIALS	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION	
							YES	NO
<i>sh</i>		60243604	03/12/85	EPO	—	—	Abstract	
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<i>sh</i>	International Search Report for PCT/US01/51095

Examiner: <i>SK/KL</i>	Date Considered: 10/19/04
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<b>INFORMATION DISCLOSURE STATEMENT</b> PTO Form 1449  <i>JUL 15 2002</i> <i>JCS</i> PATENT & TRADEMARK OFFICE		Docket Number 980.1079US01		Serial Number 10/014218	
		Applicant(s) P. P. Wu et al.			
		Filing Date October 22, 2001		Group Art Unit 2877	

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<i>sk</i>		5,167,444	12/01/92	Hall	—	—	
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<i>sk</i>		5,825,792	10/20/98	Villeneuve et al.	—	—	
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<i>sk</i>	P.J. Rigole et al., "114-nm Wavelength Tuning Range of a Vertical Grating Assisted Codirectional Coupler Laser with a Super Structure Grating Distributed Bragg Reflector," <i>IEEE Photonics Technology Letters</i> , 7(7):697-699 (July 1995).
<i>sk</i>	Derickson, "Static Fizeau Interferometer Wavelength Meter", <i>Fiber Optic Test and Measurement</i> , Prentice-Hall, ISBN 0-13-534330-5, 163-165 (1998).
<i>sk</i>	U.S. Application Serial No. 09/871,230, filed May 31, 2001.
<i>sk</i>	U.S. Application Serial No. 10/015,151, filed December 11, 2001.
<i>sk</i>	U.S. Application Serial No. 10/014,278, filed December 11, 2001.
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Examiner: <i>sk</i>	Date Considered: <i>10/19/04</i>
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